Satellite Symposium of the 80th Annual Meeting

The Japanese Society of Microscopy

International Symposium for Young Scientists in State-of-the-Art Microscopy



Educational Lectures for Young Scientsts

Jun 2nd (Sun)

12:30-19:00

Hybrid Symposium

Makuhari-Messe

2F, 201

2-1, Nakase, Mihama-ku, Chiba-city, JAPAN

Free of Charge

Pre-registration required

Please use the QR code on the right or the URL below to access the form. https://sites.google.com/view/microscopy-wakate/

Appllication Deadline: May 26, 2024 (Sun)

Anyone, academic or non-academic, is welcome to attend.



This is an independent event from the annual meeting





Invited talks by young researchers

12:30 - 12:55

Development of Advanced Direct Electron Detection Cameras **Using SOI Technology** Takafumi Ishida Nagoya University, Japan

12:55 - 13:20

Utilizing 4D-STEM for Multislice Electron Tomography Yongsoo Yang Korea Advanced Institute of Science and Technology, Korea

13:30 - 13:55

Mitochondrial Ultrastructure and Its Regulation Revealed by Deep Learning-based Analysis Shoqo Suga University of Tokyo, Japan

13:55 - 14:20

MINFLUX for Dynamic Structural Biology Nikolay Sergeey University of Vienna, Austria

14:30 - 14:55

Data-driven Analysis for Revealing Sub-percent Local Strain in a Nanoparticle Kohei Aso Japan Advanced Institute of Science and Technology, Japan

14:55 - 15:20

Microscope Kintsugi: Embracing the Imperfect to Make the New Jonathan Peters Trinity College Dublin, Ireland

15:30 - 15:55

Imaging Protein Activity by High-speed AFM and 2-photon FLIM Hideji Murakoshi National Institute for Physiological Sciences, Japan

15:55 - 16:20

Genetically Encoded Multimeric Tags for Protein Localisation in Cellular Cryo-ET Yuki Hayashi European Molecular Biology Laboratory, Germany

Special invited lecture

16:30 - 17:15

Molecular Structure Determination at 100 keV and Potential Improvements in CryoEM in Situ

Christopher Russo MRC Laboratory of Molecular Biology, UK

17:15 - 18:00

2D and 4D STEM Imaging of Beam Sensitive Materials Peter Nellist University of Oxford, UK

18:00 - 18:45

In Situ Electron Microscopy for Site-specific Correlation between Atomic Structure and Properties

Eva Olsson Chalmers University of Technology, Sweden

